

<b>Notice of References Cited</b>	Application/Control No. 10/758,023	Applicant(s)/Patent Under Reexamination MURAKAMI ET AL.	
	Examiner Amara Abdi	Art Unit 2624	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0012406 A1	01-2003	Iwamura, Keiichi	382/100
*	B	US-2003/0025805 A1	02-2003	Yamagishi, Yoichi	348/222.1
*	C	US-6,532,541 B1	03-2003	Chang et al.	713/176
*	D	US-2003/0133591 A1	07-2003	Watanabe et al.	382/100
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.